

Enhancement Mode Gallium Nitride (GaN) HEMT

650 V, 27 mΩ, 64 A, PDSO-G16

NTBT035N65GN1

Features

- Low $R_{DS(ON)}$ to Minimize Conduction Losses
- Ultra Low Gate Charge for High Speed Switching
- $FOM-Q_G = 378 \text{ nC} \cdot \text{m}\Omega$
- Small Footprint for High Density PCB Design
- This Device is Halide Free and RoHS Compliant with Exemption 7a, Pb-Free 2LI (on second level interconnection)

Typical Applications

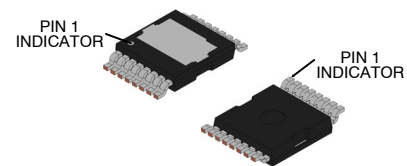
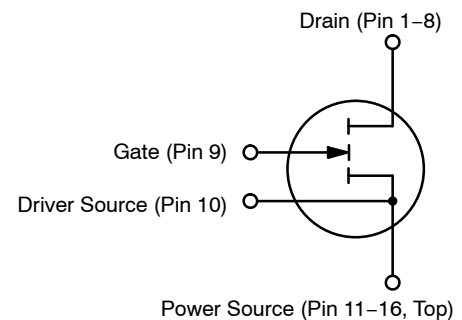
- High Density Power Modules
- High Frequency AC-DC and DC-DC Converters
- High Performance PSU for Data Center and Industrial
- Resonant Conversion

MAXIMUM RATINGS ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-to-Source Voltage	V_{DSS}	650	V
Drain-to-Source Transient Voltage, $t_p < 200 \mu\text{s}$	$V_{DS(TRAN)}$	800	V
Gate-to-Source Voltage	V_{GS}	-6 to 7	V
Gate-to-Source Transient Voltage, $t_p = 50 \text{ ns}$, $f_p = 100 \text{ kHz}$, open drain	$V_{GS(PULSE)}$	-20 to 10	V
Continuous Drain Current, $T_{CASE} = 25^\circ\text{C}$ $T_{CASE} = 100^\circ\text{C}$	I_{DS}	64 45	A
Pulsed Drain Current, $t_p < 10 \mu\text{s}$, $T_J = 25^\circ\text{C}$ $T_J = 125^\circ\text{C}$	$I_{DS(PULSE)}$	127 64	A
Power Dissipation, $V_{GS} = 6 \text{ V}$, $T_{CASE} = 25^\circ\text{C}$	P_{TOT}	462	W
Operating Junction Temperature	T_J	-55 to 150	$^\circ\text{C}$
Storage Temperature	T_{STG}	-55 to 150	$^\circ\text{C}$

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

$V_{(BR)DSS}$	$R_{DS(ON)} \text{ TYP}$	$I_{DS} \text{ MAX}$
650 V	27 mΩ	64 A



PDSO-G16 9.90 x 10.15 x 2.30, 1.20P
CASE 208AA

MARKING DIAGRAM



BT035N65GN1 = Specific Device Code
A = Assembly Site
YY = Year of Production
WW = Work Week Number
ZZZ = Assembly Lot Number

ORDERING INFORMATION

See detailed ordering and shipping information on page 7 of this data sheet.

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THERMAL CHARACTERISTICS

Parameter	Symbol	Value	Unit
Junction-to-Cases	$R_{\theta JC}$	0.27	$^{\circ}\text{C/W}$
Junction-to-Ambient (Note 1)	$R_{\theta JA}$	49	$^{\circ}\text{C/W}$
Maximum Soldering Temperature (MSL3)	T_{SLD}	260	$^{\circ}\text{C}$

1. Device on 1 in², 2 oz copper pad on single layer FR-4 PCB

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}\text{C}$ unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
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OFF CHARACTERISTICS

Drain-to-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0\text{ V}$	650			V
Drain-to-Source Leakage Current	I_{DSS}	$V_{GS} = 0\text{ V}, V_{DS} = 650\text{ V}$		11	143	μA
		$V_{GS} = 0\text{ V}, V_{DS} = 650\text{ V}, T_J = 125^{\circ}\text{C}$ (Note 3)		29		
Gate-to-Source Leakage Current	I_{GSS}	$V_{GS} = 6\text{ V}, V_{DS} = 0\text{ V}$		358		μA
		$V_{GS} = 6\text{ V}, V_{DS} = 0\text{ V}, T_J = 125^{\circ}\text{C}$ (Note 3)		1253		μA

ON CHARACTERISTICS (Note 2)

Drain-to-Source On Resistance	$R_{DS(ON)}$	$V_{GS} = 6\text{ V}, I_{DS} = 18\text{ A}$		27	35	$\text{m}\Omega$
		$V_{GS} = 6\text{ V}, I_{DS} = 18\text{ A}, T_J = 125^{\circ}\text{C}$ (Note 3)		50		
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS} = V_{GS}, I_{DS} = 67.4\text{ mA}, T_J = 25^{\circ}\text{C}$	1.2	1.5	2.5	V
		$V_{DS} = V_{GS}, I_{DS} = 67.4\text{ mA}, T_J = 125^{\circ}\text{C}$ (Note 3)		1.4		

DYNAMIC CHARACTERISTICS (Note 3)

Input Capacitance	C_{ISS}	$V_{DS} = 400\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$		498		pF
Output Capacitance	C_{OSS}			172		
Reverse Transfer Capacitance	C_{RSS}			2.3		
Output Capacitance, Energy Related	$C_{OSS(ER)}$	$V_{DS} = 0\text{ V to } 400\text{ V}, V_{GS} = 0\text{ V}$		250		pF
Output Capacitance, Time Related	$C_{OSS(TR)}$			355		
Output Charge	Q_{OSS}			142		nC
Output Capacitance Stored Energy	E_{OSS}			20		μJ
Gate Resistance	R_G	$f = 5\text{ MHz}$		1.6		Ω
Gate Charge	Q_G	$V_{DS} = 400\text{ V}, I_{DS} = 18\text{ A}, V_{GS} = 0/6\text{ V}$		16		nC
Gate-to-Source Charge	Q_{GS}			4.6		
Gate-to-Drain Charge	Q_{GD}			2.5		
Gate Plateau Voltage	V_{PLAT}			2.3		V

SWITCHING CHARACTERISTICS (Note 3)

Turn-On Delay Time	$t_{D(ON)}$	$V_{DS} = 400\text{ V}, I_{DS} = 18\text{ A}, V_{GS} = 0/6\text{ V},$ $R_G = 5\ \Omega, R_{G,OFF} = 3\ \Omega$		6.2		ns
Turn-Off Delay Time	$t_{D(OFF)}$			11		ns
Turn-On Rise Time	t_R			8.2		ns
Turn-Off Fall Time	t_F			12		ns



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ELECTRICAL CHARACTERISTICS ($T_J = 25\text{ }^{\circ}\text{C}$ unless otherwise specified) (continued)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
REVERSE CONDUCTION CHARACTERISTICS						
Source-to-Drain Reverse Voltage	V_{SD}	$V_{GS} = -3\text{ V}, I_{SD} = 18\text{ A}$ (Note 3)		5.2		V
		$V_{GS} = 0\text{ V}, I_{SD} = 18\text{ A}$		2.4		
		$V_{GS} = 6\text{ V}, I_{SD} = 18\text{ A}$ (Note 3)		0.5		

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

2. No prior drain bias or switching stress is applied during the measurement of $V_{GS(TH)}$ and $R_{DS(ON)}$.

3. Defined by design, not subject to production test.



TYPICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise specified)

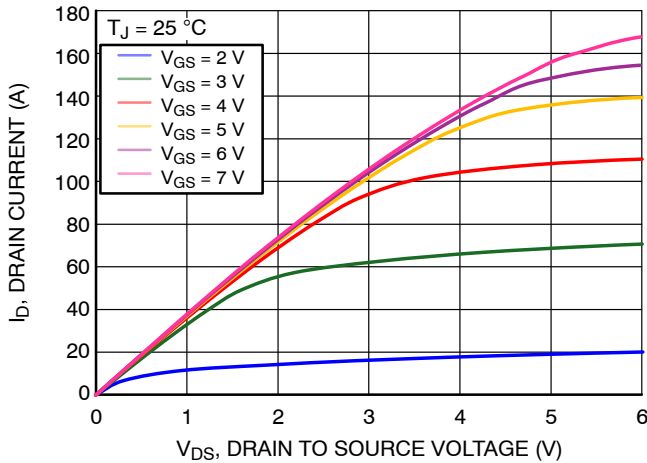


Figure 1. Output Characteristics at $T_J = 25^\circ\text{C}$

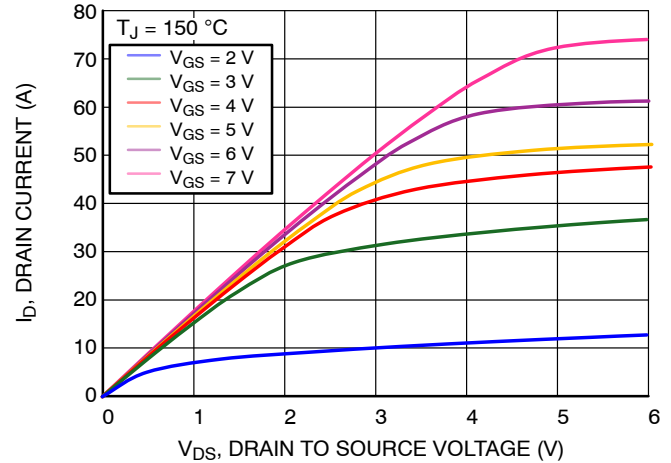


Figure 2. Output Characteristics at $T_J = 125^\circ\text{C}$

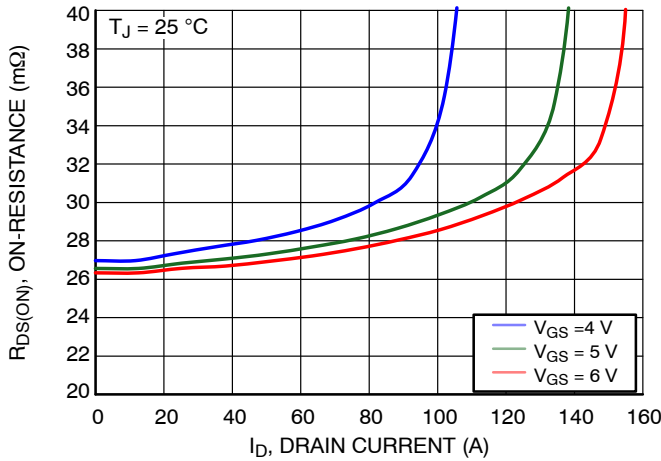


Figure 3. On-Resistance vs. Drain Current at $T_J = 25^\circ\text{C}$

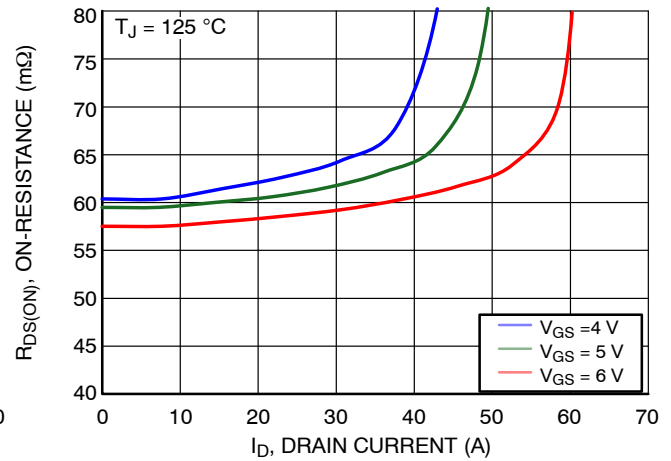


Figure 4. On-Resistance vs. Drain Current at $T_J = 25^\circ\text{C}$

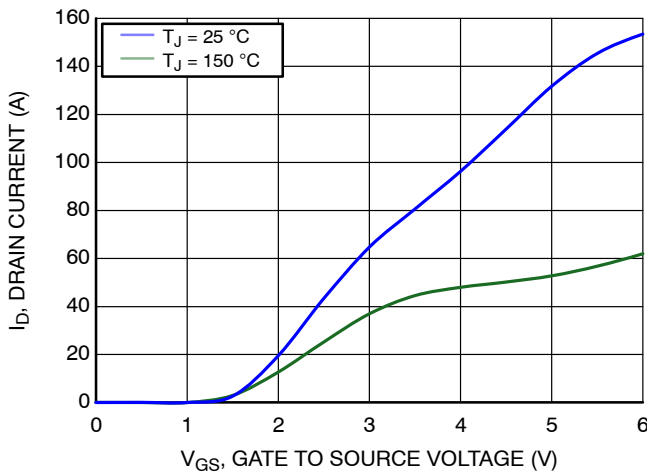


Figure 5. Transfer Characteristics at $V_{DS} = 3\text{ V}$

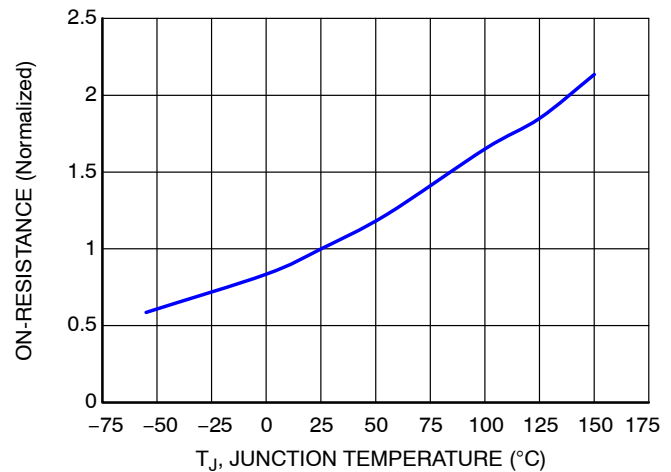


Figure 6. Normalized On-Resistance vs. Temperature at $V_{GS} = 6\text{ V}$

TYPICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise specified)

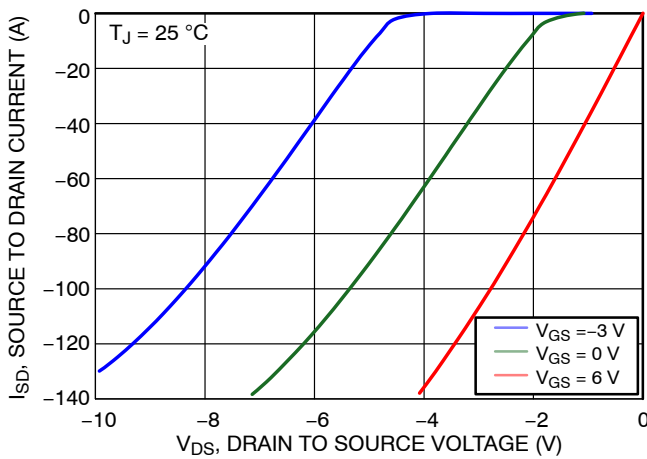


Figure 7. Reverse Conduction Characteristics at $T_J = 25^\circ\text{C}$

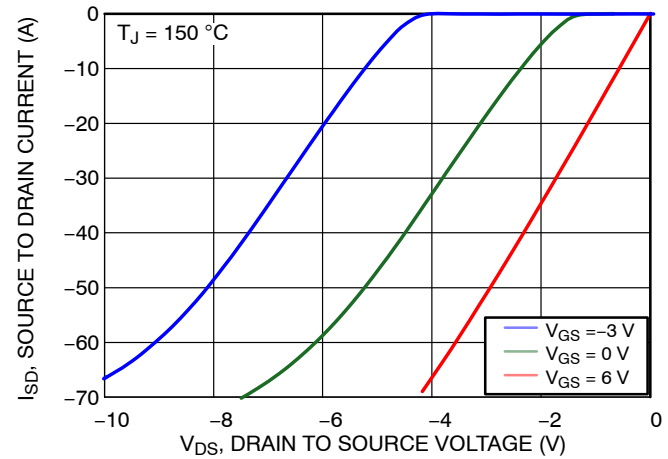


Figure 8. Reverse Conduction Characteristics at $T_J = 125^\circ\text{C}$

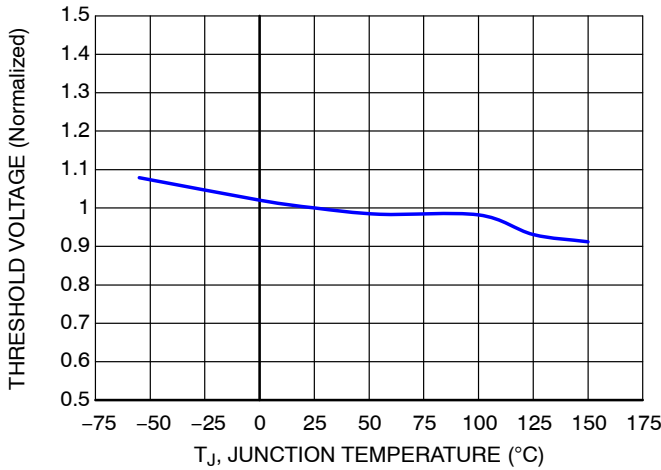


Figure 9. Normalized Threshold Voltage vs. Temperature

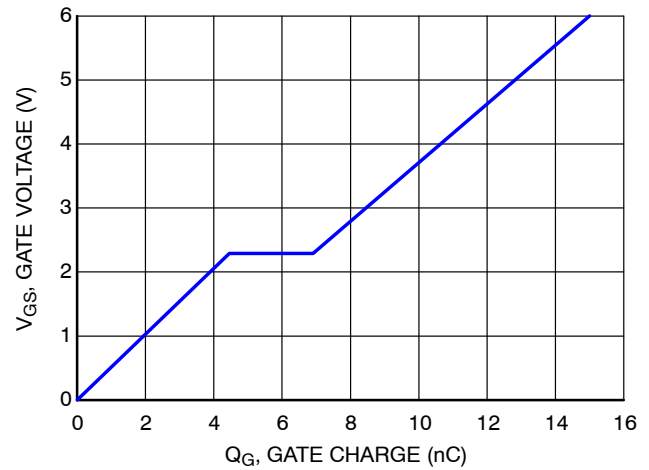


Figure 10. Gate Charge Characteristics at $I_{DS} = 18\text{ A}$

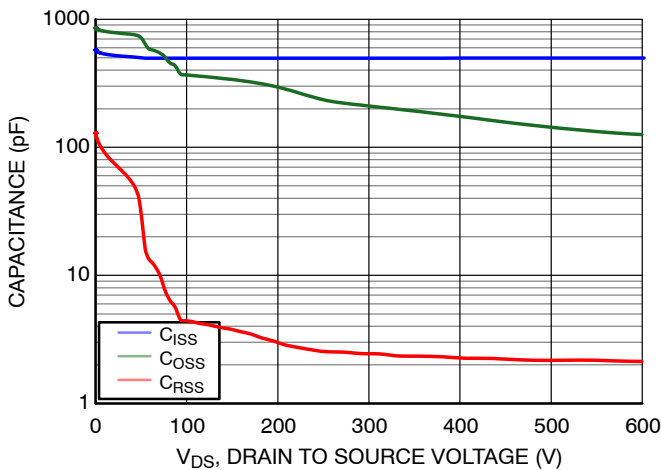


Figure 11. Capacitance Characteristics

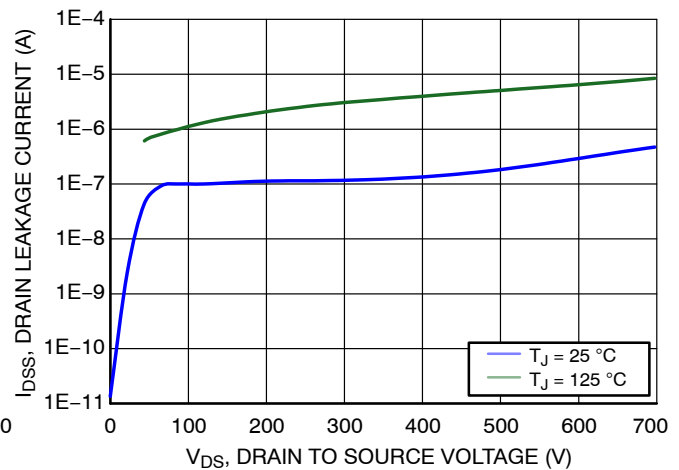


Figure 12. Drain Leakage Characteristics

TYPICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise noted)

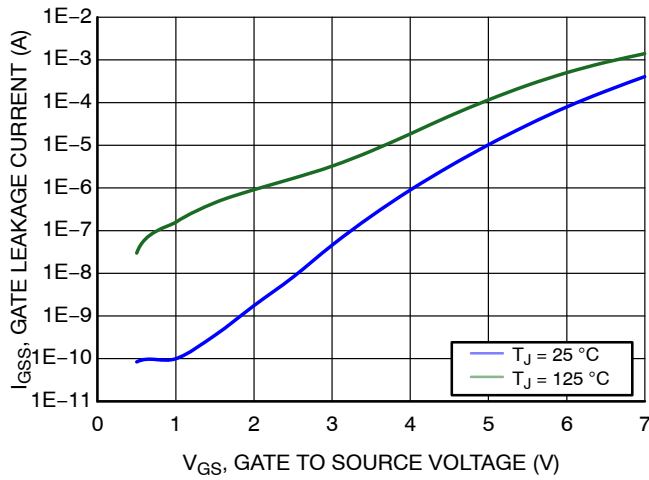


Figure 13. Gate Leakage Characteristics

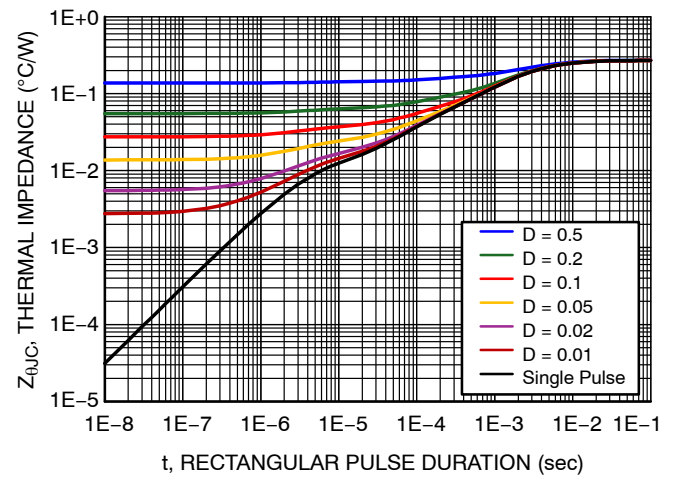


Figure 14. Transient Thermal Impedance

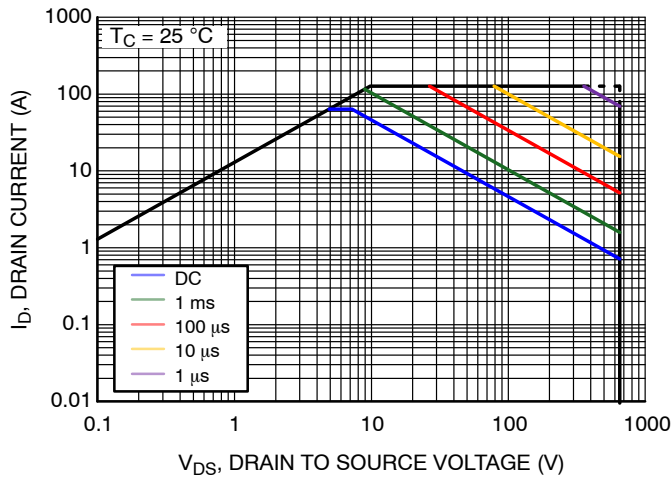


Figure 15. Safe Operating Area at $T_C = 25^\circ\text{C}$

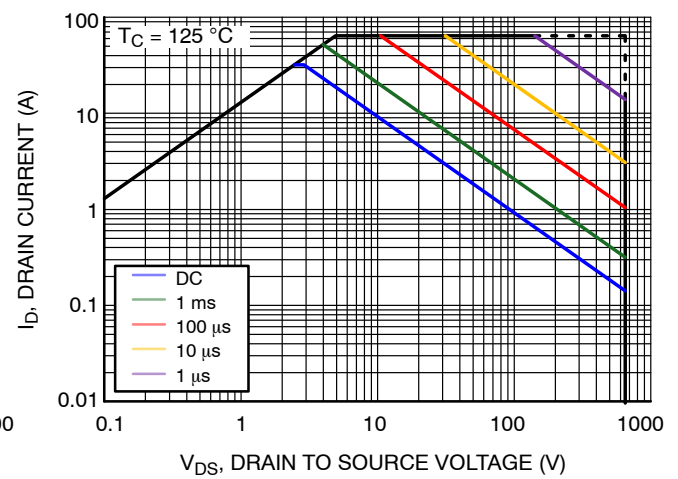


Figure 16. Safe Operating Area at $T_C = 125^\circ\text{C}$

Gate Drive Guidelines

This GaN device utilizes a Schottky gate structure, which behaves similarly to a MOSFET with a purely capacitive input and does not require continuous gate current during the on-state. For optimal performance, apply a low-impedance gate driver with appropriate gate resistance to control switching speed and limit ringing. A typical gate voltage of

6 V is recommended, with optional negative gate bias for hard-switching applications to improve dv/dt immunity and prevent false turn-on. Minimize gate loop inductance (<1 nH) through careful PCB layout and short connections. For additional robustness, Zener clamps may be used to limit gate voltage in both polarities.

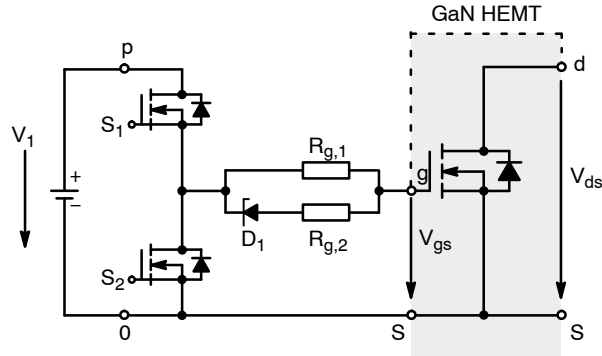


Figure 17. Schottky Gate Conventional Driver Schematic

ORDERING INFORMATION

Device Order Number	Package Type	Shipping [†]
NTBT035N65GN1TXG	PDSO-G16 9.90 x 10.15 x 2.30, 1.20P	1200 / Tape & Reel

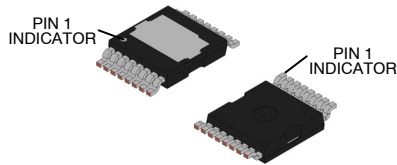
[†] For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, [BRD8011/D](#).

NTBT035N65GN1

REVISION HISTORY

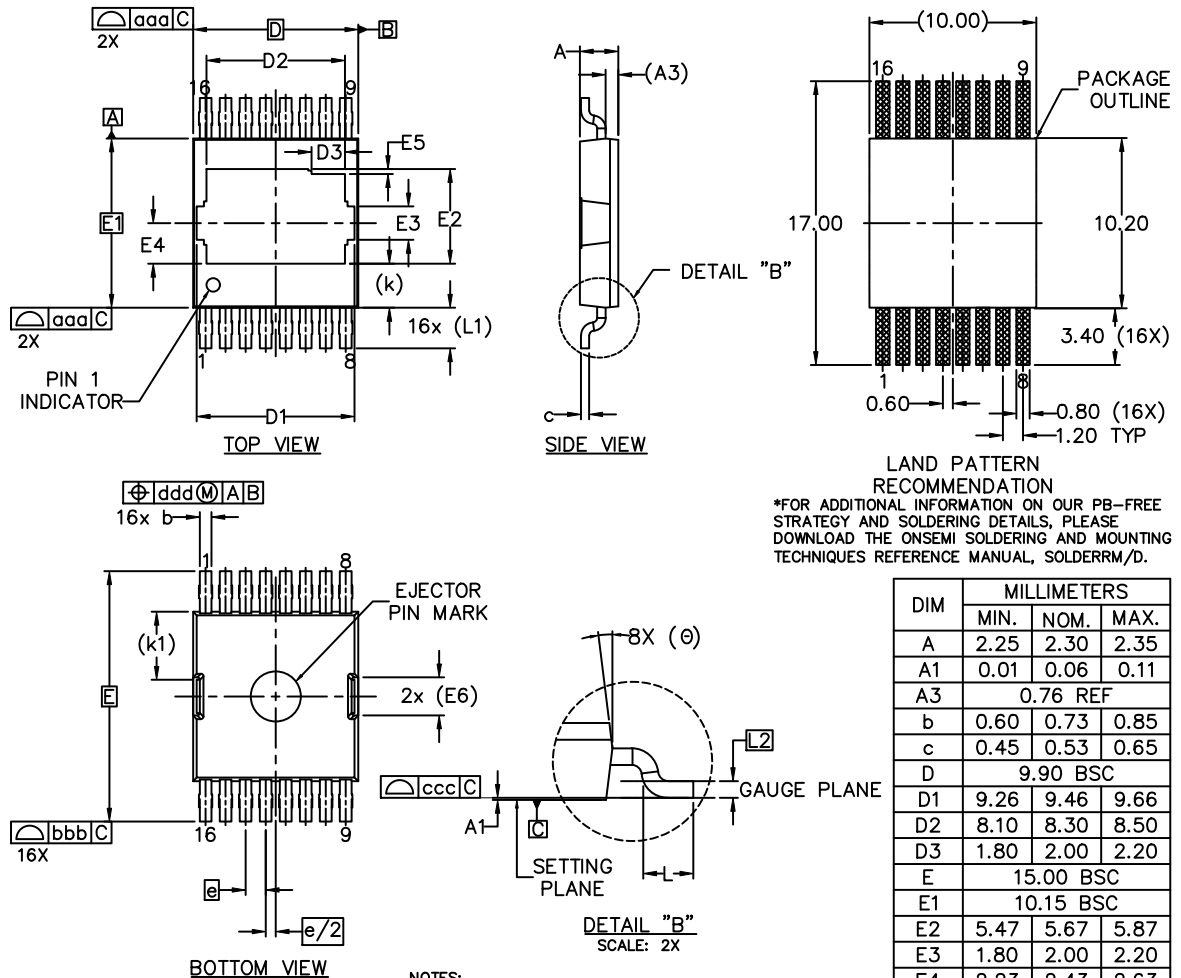
Revision	Description of Changes	Date
0	Initial document release.	7/29/2026





PDSO-G16 9.90x10.15x2.30, 1.20P
CASE 208AA
ISSUE A

DATE 12 AUG 2026



GENERIC MARKING DIAGRAM*



XXXX = Specific Device Code
A = Assembly Location
YY = Year
WW = Work Week
ZZZ = Assembly Lot Code

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

- NOTES:**
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-2018.
 2. ALL DIMENSIONS ARE IN MILLIMETERS, ANGLES IN DEGREES.
 3. DIMENSIONS D AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSION OR MOLD GATE REMAIN. MOLD FLASH PROTRUSION SHALL NOT EXCEED 0.150mm PER SIDE AND MOLD GATE REMAIN SHALL NOT EXCEED 0.300mm.
 4. DIMENSIONS D AND E1 ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
 5. THE LOCATION AND SIZE OF EJECTOR MARKS ARE OPTIONAL.
 6. DIMENSION A1 IS THE LEAD STAND-OFF FROM THE BOTTOM SURFACE OF THE PACKAGE BODY.

DIM	MILLIMETERS		
	MIN.	NOM.	MAX.
A	2.25	2.30	2.35
A1	0.01	0.06	0.11
A3	0.76 REF		
b	0.60	0.73	0.85
c	0.45	0.53	0.65
D	9.90 BSC		
D1	9.26	9.46	9.66
D2	8.10	8.30	8.50
D3	1.80	2.00	2.20
E	15.00 BSC		
E1	10.15 BSC		
E2	5.47	5.67	5.87
E3	1.80	2.00	2.20
E4	2.23	2.43	2.63
E5	0.10	0.30	0.50
E6	2.28 REF		
e	1.20 BSC		
e/2	0.60 BSC		
k	2.65 REF		
k1	4.08 REF		
L	1.30	1.50	1.70
L1	2.45 REF		
L2	0.50 BSC		
Ø	4*	7*	10*
aaa	0.20		
bbb	0.20		
ccc	0.10		
ddd	0.25		

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